

TECHNICAL SPECIFICATION

**Power quality measurement in power supply systems -
Part 3: Maintenance tests, calibration**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

Power quality measurement in power supply systems - Part 3: Maintenance tests, calibration

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The text of this Technical Specification is based on the following documents:

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Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this Technical Specification is English.